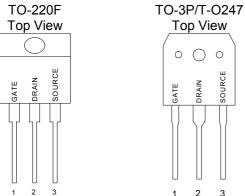


GENERAL DESCRIPTION

This high voltage MOSFET uses an advanced termination scheme to provide enhanced voltage-blocking capability without degrading performance over time. In addition, this advanced MOSFET is designed to withstand high energy in avalanche and commutation modes. The new energy efficient design also offers a drain-to-source diode with a fast recovery time. Designed for high voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer additional and safety margin against unexpected voltage transients.

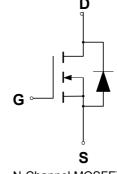
PIN CONFIGURATION



FEATURES

- Robust High Voltage Termination
- Avalanche Energy Specified
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Diode is Characterized for Use in Bridge Circuits
- ♦ I_{DSS} and V_{DS}(on) Specified at Elevated Temperature
- Isolated Mounting Hole Reduces Mounting Hardware

SYMBOL



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain to Current – Continuous	ID	20.5	А
- Pulsed	I _{DM}	82	
Gate-to-Source Voltage – Continue	V_{GS}	±30	V
Total Power Dissipation – TO220FP	PD	54	W
– TO3P		245	W/°C
– TO247		210	
Derate above 25°C – TO220FP		0.29	
– TO3P		2	
– TO247		1.8	
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to 150	°C
Single Pulse Drain-to-Source Avalanche Energy $-$ T _J = 25 $^\circ\!\mathbb{C}$	E _{AS}	1805	
$(V_{DD} = 100V, V_{GS} = 10V, I_L = 19A, L = 10mH, R_G = 25\Omega)$			mJ
Thermal Resistance – Junction to Case -TO220FP	θ_{JC}	3.3	°C/W
 Junction to Case -TO3P 		0.5	
 Junction to Case -TO247 		0.66	
 Junction to Ambient -TO220FP 	θ_{JA}	62.5	
 Junction to Ambient -TO3P, TO247 		40	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	°C
ESD SENSITIVITY – HBM, C=100pF, R=1.5kΩ	Vesd	2000	V

ORDERING INFORMATION

Package
TO-220F
TO-3P
TO-247
TO-220F

*Note: G : Suffix for PB Free Product

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, T_J = 25 $^\circ\!\mathrm{C}$.

			GPT21N50			
Characteristic		Symbol	Min	Тур	Мах	Units
Drain-Source Breakdown Voltage		N/	500			V
$(V_{GS} = 0 V, I_D = 250 \mu A)$		V _{(BR)DSS}	500			v
Drain-Source Leakage Current						
$(V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V})$		I _{DSS}			1	uA
$(V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 125^{\circ}C)$	125°C)				10	uA
Gate-Source Leakage Current-Forward		IGSSE			100	nA
$(V_{gsf} = 30 \text{ V}, V_{DS} = 0 \text{ V})$		IGSSF			100	
Gate-Source Leakage Current-Reverse	9	IGSSR			100	nA
$(V_{gsr} = 30 \text{ V}, V_{DS} = 0 \text{ V})$		IGSSR			100	IIA
Gate Threshold Voltage		V _{GS(th)}	3		5	V
$(V_{DS} = V_{GS}, I_{D} = 250 \ \mu A)$		V GS(th)				
Static Drain-Source On-Resistance (V_{GS} = 10 V, I_{D} = 10A) *		R _{DS(on)}		0.20	0.24	Ω
Forward Transconductance (V_{DS} = 50 V, I_D = 10A) *		g fs		22		S
Input Capacitance	$(V_{DS} = 25 V, V_{GS} = 0 V,$	C _{iss}		3300.9		pF
Output Capacitance	(, ,	C _{oss}		353.2		pF
Reverse Transfer Capacitance	f = 1.0 MHz)	Crss		19.27		pF
Turn-On Delay Time	$(V_{DD} = 250 \text{ V}, \text{ I}_{D} = 18 \text{ A}, \text{ R}_{G} = 25\Omega) *$	t _{d(on)}		38		ns
Rise Time		tr		80.8		ns
Turn-Off Delay Time		t _{d(off)}		123		ns
Fall Time		t _f		66.4		ns
Total Gate Charge	- (V _{DS} = 400 V, I _D = 18 A, V _{GS} = 10 V)*	Qg		71.5		nC
Gate-Source Charge		Q _{gs}		16.4		nC
Gate-Drain Charge		Q _{gd}		29		nC
	SOURCE-DRAIN DIODE CHA	RACTERISTICS				
Forward On-Voltage(1)	(I _S = 18 A, d _{IS} /d _t = 100A/µs)	V _{SD}			1.5	V
Forward Turn-On Time		t _{on}		**		ns
Reverse Recovery Time		t _{rr}		500		ns

* Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 2%

** Negligible, Dominated by circuit inductance



GPT21N50 / GPT21N50D

POWER FIELD EFFECT TRANSISTOR

TYPICAL ELECTRICAL CHARACTERISTICS

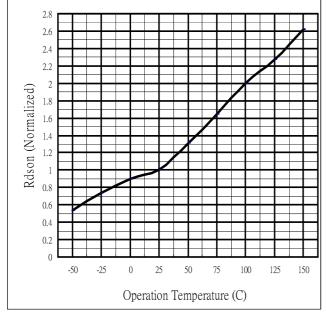


Fig 1. On-Resistance Variation with vs. Temperature

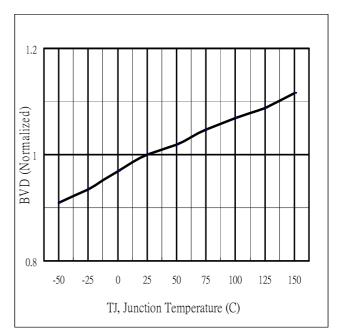


Fig.2 Breakdown Voltage Variation vs. Temperature

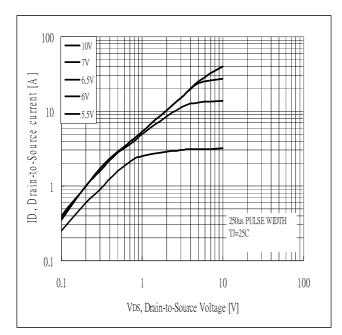


Fig 3. Typical Output Characteristics

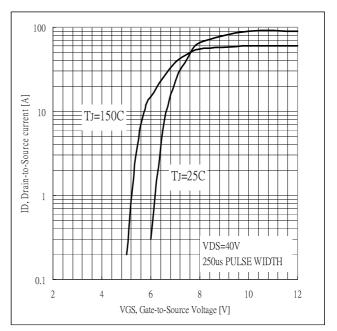


Fig 4. Typical Transfer Characteristics



GPT21N50 / GPT21N50D

POWER FIELD EFFECT TRANSISTOR

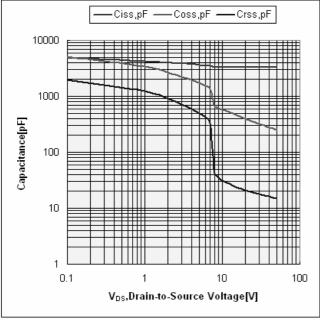
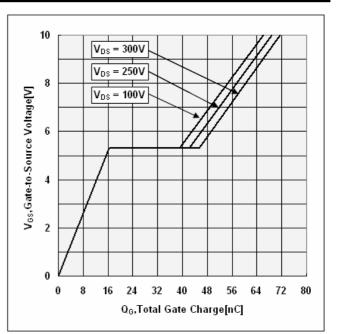


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

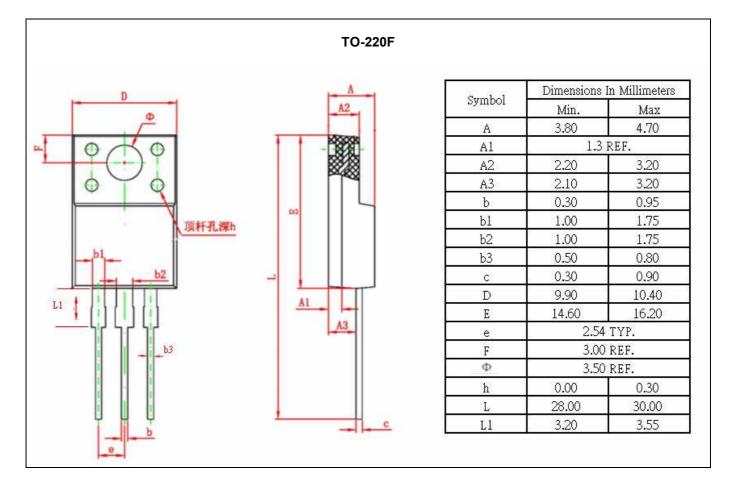






GPT21N50 / GPT21N50D Power Field Effect Transistor

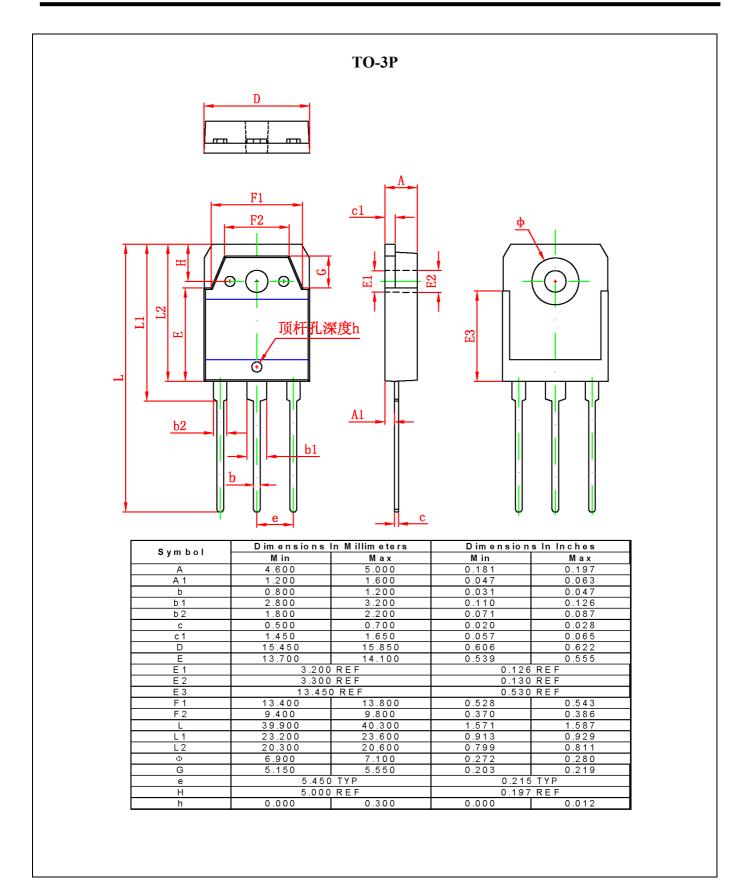
PACKAGE DIMENSION





GPT21N50 / GPT21N50D

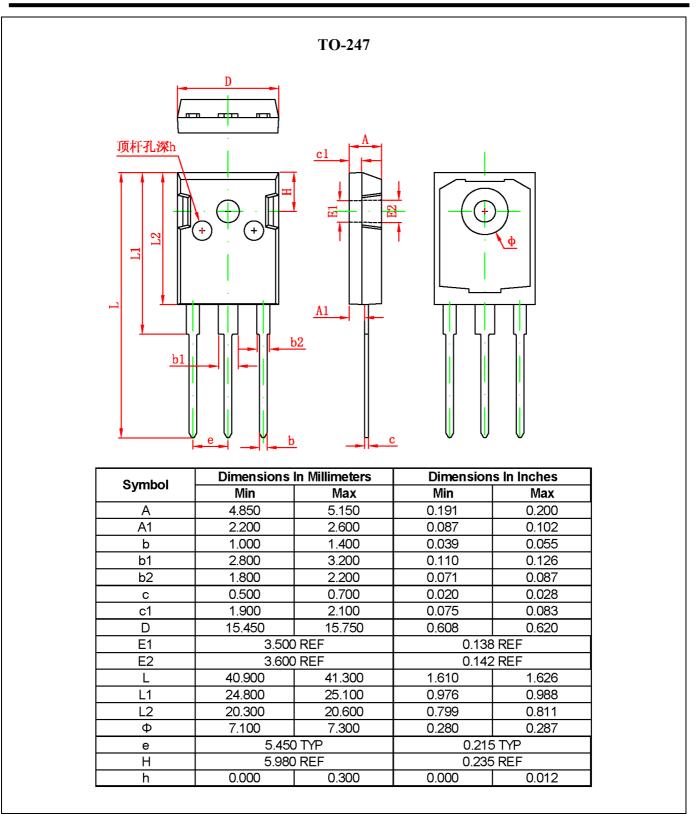
POWER FIELD EFFECT TRANSISTOR



✓/> CHAMPION 虹冠電子

GPT21N50 / GPT21N50D

POWER FIELD EFFECT TRANSISTOR





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